

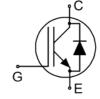
TRENCHSTOPTM RC-Series for hard switching applications

IGBT chip with monolithically integrated diode in packages offering space saving advantage

Features:

TRENCHSTOPTM Reverse Conducting (RC) technology for 600V applications offering:

- \bullet Optimised V_{CEsat} and V_{F} for low conduction losses
- Smooth switching performance leading to low EMI levels
- Very tight parameter distribution
- Operating range of 1 to 20kHz
- Maximum junction temperature 175°C
- Short circuit capability of 5µs
- Best in class current versus package size performance
- Qualified according to JEDEC for target applications
- Complete product spectrum and PSpice Models: http://www.infineon.com/igbt/



Applications:

Used for:

Motor drives

Discrete components and molded modules

Chip Type	V _{CE}	<i>I</i> _{Cn}	Die Size	Package		
IGC05R60DE	600V	6A	2.21 x 2.19 mm ²	sawn on foil		
Mechanical Paramet	ers					
Raster size			2.21	x 2.19		
Emitter pad size			see chip	2		
Gate pad size			see chip	o drawing	mm ²	
Area: total / active IGE	BT / active Dic	ode	4.84 / 2.2	219 / 0.477		
Thickness			-	70	μm	
Wafer size			2	200 m		
Max.possible chips per wafer			5775			
Passivation frontside			Photoimide			
Pad metal			3200 nm AlSiCu			
Backside metal			Ni Ag -system			
Die bond			Electrically conductive epoxy glue and soft solder (temperature budget: 290°C for 1min. or 260°C for 1.5min.)			
Wire bond			Al, <250μm			
Reject ink dot size			Ø 0.65mm ; max 1.2mm			
Storage environment for open MBB bags			Ambient atmosphere air, Temperature 17°C – 25°C, < 6 month			
		B bags	Acc. to IEC62258-3: Atmosphere >99% Nitrogen or inert gas, Humidity <25%RH, Temperature 17°C – 25°C, < 6 month			



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Maximum Ratings

Parameter	Symbol	Value	Unit	
Collector-Emitter voltage, T_{vj} =25 °C	V _{CE}	600	V	
DC collector current, limited by $T_{\rm vjmax}$	I _C	1)	А	
Pulsed collector current, t_p limited by $T_{v_{j max}}$	I _{c,puls}	18	А	
Gate emitter voltage	V _{GE}	±20	V	
Junction temperature range	$T_{\rm vj,max}$	-40+175	°C	
Operating junction temperature	$T_{vj,op,max}$	-40+175	°C	
Short circuit data ²⁾³⁾ $V_{GE} = 15V$, $V_{CC} = 400V$, $T_{vj} = 150$ °C	tsc	5	μs	
Safe operating area IGBT ²) ³⁾	$I_{C,max} = 12A, V_{CE,max} = 600V, T_{vj,op} \le T_{vj,op,max}$			
Safe operating area Diode ²⁾	$I_{F,max} = 12A, V_{R,max} = 600V,$ $P_{max} = 4.8 \text{ kW}, T_{vj,op} \le T_{vj,op,max}$			

Static Characteristics (tested on wafer), T_{vj} =25 °C

Parameter	Symbol	Conditions	Value			Unit
- urumotor			min.	typ.	max.	
Collector-Emitter breakdown voltage	V _{(BR)CES}	$V_{\rm GE}$ =0V , $I_{\rm C}$ = 0.2 mA	600			
Collector-Emitter saturation voltage	V _{CEsat}	V _{GE} =15V, I _C =6A		1.65	2.1	V
Diode Forward Voltage	V _F	V _{GE} =0V, I _F =6A		1.7	2.1	V
Gate-Emitter threshold voltage	$V_{\rm GE(th)}$	$I_{\rm C}$ =0.11mA , $V_{\rm GE}$ = $V_{\rm CE}$	4.3	5	5.7	
Zero gate voltage collector current	I _{CES}	V_{CE} =600V , V_{GE} =0V			40	μA
Gate-Emitter leakage current	I _{GES}	V_{CE} =0V , V_{GE} =20V			100	nA
Integrated gate resistor	$r_{\rm G}$			none		Ω

Electrical Characteristics (not subject to production test - verified by design / characterization)

Parameter		Symbol	Conditions	Value			Unit
				min.	typ.	max.	Ollit
Collector-Emitter saturation voltage	<i>T</i> _{vj} =175 °C	V _{CEsat}	V _{GE} =15V, I _C =6A		1.85		V
Input capacitance		Cies	V _{CE} =25V,		470		
Output capacitance		Coes	$V_{GE}=0V$, $f=1MHz$		24		pF
Reverse transfer capacitance		C _{res}	<i>T</i> _{vj} =25 °C		14		

depending on thermal properties of assembly
 not subject to production test - verified by design/characterization

³⁾ allowed number of short circuits: <1000; time between short circuits: >1s

IGC05R60DE



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Further Electrical Characteristic

Switching characteristics and thermal properties are depending strongly on package design and mounting technology and can therefore not be specified for a bare die.

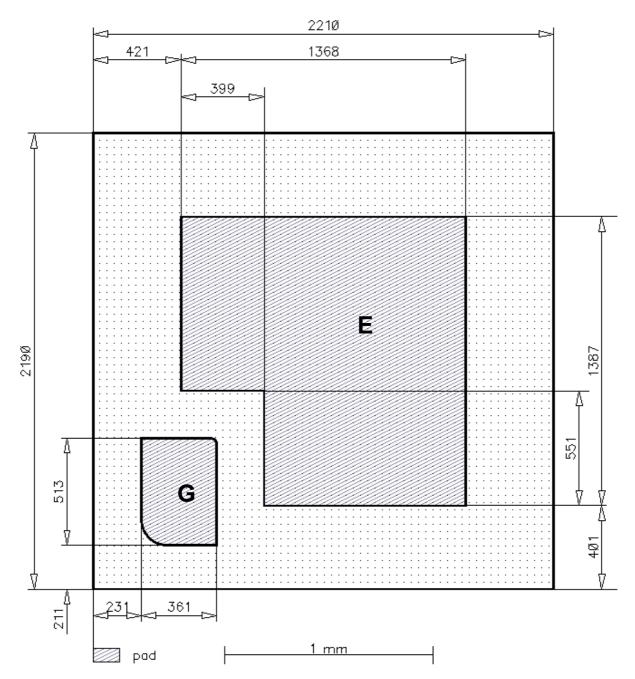
Further technical information about the performance of this chip in package PG-TO252-3 is given exemplarily at www.infineon.com/igbt. The chip qualification is independent of the qualification which is performed for the Discretes.

This chip data sheet refers to the device data sheet	IKD06N60R	Rev. 2.2



Chip Drawing



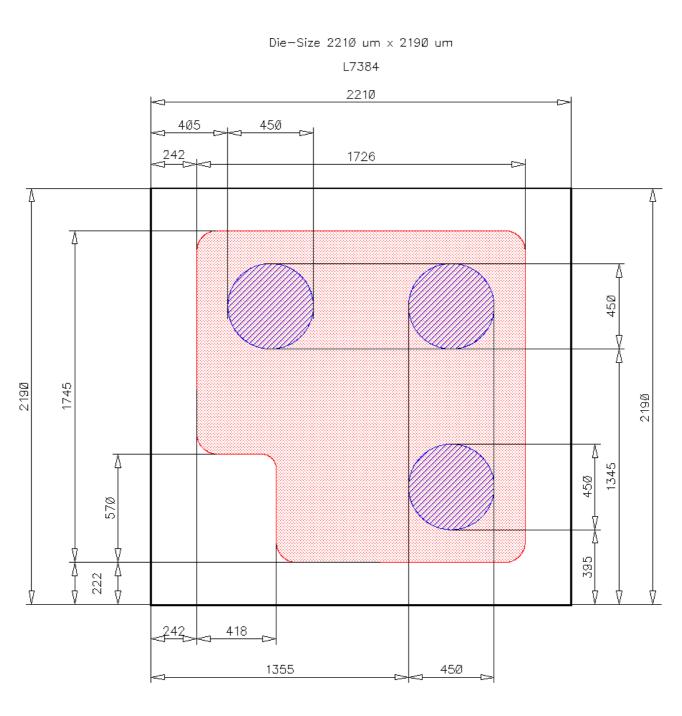


E = Emitter

G = Gate



Chip Drawing active areas



Diode: Active Area
IGBT: Active Area

IGC05R60DE



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Description
AQL 0,65 for visual inspection according to failure catalogue
Electrostatic Discharge Sensitive Device according to MIL-STD 883

Revision History

Version	Subjects (major changes since last revision)	Date

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The Infineon Technologies component described in this Data Sheet may be used in life-support devices or systems and/or automotive, aviation and aerospace applications or systems only with the express written approval of Infineon Technologies, if a failure of such components can reasonably be expected to cause the failure of that life-support, automotive, aviation and aerospace device or system or to affect the safety or effectiveness of that device or system. Life support devices or systems are intended to be implanted in the human body or to support and/or maintain and sustain and/or protect human life. If they fail, it is reasonable to assume that the health of the user or other persons may be endangered.